


<b>Search Notes</b> 	<b>Application/Control No.</b> 10500401	<b>Applicant(s)/Patent Under Reexamination</b> OIWA ET AL.
	<b>Examiner</b> SYED Y HASAN	<b>Art Unit</b> 2621

SEARCHED			
Class	Subclass	Date	Examiner
386	92	3/19/2008	Syed Y. Hasan
386	68	3/19/2008	Syed Y. Hasan
386	83	3/19/2008	Syed Y. Hasan
386	125	3/19/2008	Syed Y. Hasan
386	E5.002	3/19/2008	Syed Y. Hasan
386	E9.013	3/19/2008	Syed Y. Hasan
369	30.2	3/19/2008	Syed Y. Hasan
369	47.16	3/19/2008	Syed Y. Hasan
369	47.24	3/19/2008	Syed Y. Hasan
369	47.29	3/19/2008	Syed Y. Hasan
369	124.04	3/19/2008	Syed Y. Hasan
369	124.14	3/19/2008	Syed Y. Hasan
369	275.3	3/19/2008	Syed Y. Hasan
370	498	3/19/2008	Syed Y. Hasan
707	200	3/19/2008	Syed Y. Hasan
711	112	3/19/2008	Syed Y. Hasan
725	146	3/19/2008	Syed Y. Hasan
348	E5.105, E7.061	2/26/2009	Syed Y. Hasan
386	109, 112	2/26/2009	Syed Y. Hasan
711	153, 173	2/26/2009	Syed Y. Hasan
725	38, 40, 44, 55, 59, 61, 89, 133, 134, 141, 153	2/26/2009	Syed Y. Hasan

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB	3/19/2008	Syed Y. Hasan
Consultation with James Fletcher	3/18/2008	Syed Y. Hasan

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--